LIST OF	U.S. DEPARTMENT OF COMMERCENT AND TRADEMARK OFFICE	E	Atty. Docket No. 12435 Applicants		Serial No. 10/567,026		
CITEDE	BY APPLICANT		Stephan T. Melnychul	k, et al.	<u> </u>		
(Use several sheets if necessary)			Filing Date January 10, 2007		Group Art Unit 2882		
U.S. PAT	ENT DOCUMENTS						
EXAMINE R INITIAL*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLAS S	FILING DA (if appropri	
	3,426,420	1966-04-08	Grant, et al.				
	4,266,138	1981-05-05	Nelson, Jr., et al.				
	4,431,709	1984-02-14	Bronnes, et al.				
	4,864,142	1989-09-05	Gomberg				
	5,040,200	1991-08-13	Ettinger, et al.				
	5,124,554	1992-06-23	Fowler, et al.				
U.S. PAT	ENT PUBLICATION DOC	CUMENTS	I		1		***************************************

FOREIGI	N PATENT DOCUMENTS						-110
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLAS S	TRANSLATION	
						YES	МО
				-			
~~~~~~~~~~						MIRAN COLOR TO THE	<del>.</del>
<u> </u>							
OTHER I	PRIOR ART (Including A	uthor, Title, Da	ate, Pertinent Pages, E	Etc.)			
						······································	
			www.tiwww.ana.ana.ana.ana.ana.ana.ana.ana.ana.				
***************************************			T		·····		***************************************
EXAMINER			DATE CONSIDERED				
* EXAMINER	R: Initial if reference considered, se and not considered. Include co	whether or not cital ppy of this form with	tion is in conformance with MF n next communication to appli	PEP 609; draw li cant.	ne through cita	tion if not in	

FORM PTO-1449 U.S. DEPAR (REV. 7-80)PATENT AND TRADEMAR LIST OF PRIOR AF CITED BY APPLIC		E	Atty. Docket No.					
			12435	Serial No. 10/567,026				
			Applicants Stephan T. Melnychu	k, et al.				
(Use several sheets if necessary)			Filing Date January 10, 2007	Group Art Unit 2882				
U.S. PATENT DOCU	MENTS							
EXAMINE DOCU R INITIAL*	MENT NUMBER	DATE	NAME	CLASS	SUBCLAS S		G DATE opriate)	
5,278	3,418	1994-01-11	Broadhurst					
5,323	3,004	1994-06-21	Ettinger, et al.					
5,338	3,934	1994-08-16	Morohashi, et al.					
5,461	,657	1995-10-24	Hayashida, et al.					
5,740	,228	1998-04-14	Schmidt, et al.					
5,784	,430	1998-07-21	Sredniawski					
5,814	,821	1998-09-29	Reusch, et al.					
5,825	,848	1998-10-20	Virshup, et al.					
5,917	<b>'</b> ,874	1999-06-29	Schlyer, et al.				***************************************	
6,215	5,851	2001-04-10	Meilunas, et al.					
U.S. PATENT PUBLI	CATION DO	CUMENTS		1				
FOREIGN PATENT I	OCUMENTS							
DOCU	MENT NUMBER	DATE	COUNTRY	CLASS	SUBCLAS	TRANSLATION		
					S	YES	NO	
OTHER PRIOR ART	(Including A	uthor, Title, Da	ite, Pertinent Pages, E	Etc.)				
Baue "Rad	Bauer, C., et al., Nuclear Instruments and Methods in Physics Research A. 367 (1995) 207-211: "Radiation hardness studies of SVD diamond detectors"							
	Hassard, J., et al., <u>Nuclear Instruments and Methods in Physics Research A</u> . <u>416</u> (1998) 539-542: "CVD diamond film for neutron counting"							
EXAMINER			DATE CONSIDERED					